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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,353	TSUCHIYA ET AL.	
Examiner	Art Unit	
	0050	

SEARCHED				
OLAKO II LO				
Class	Subclass	Date .	Examiner	
347	85	11/28/2006	LEM	
347	86	11/28/2006	LEM	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
347	85, 86	11/28/2006	LEM

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
See attached search history	11/28/2006	LEM	